

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST
CERTIFICATES FOR ELECTRICAL EQUIPMENT
(IECEE) CB SCHEME

SYSTEME CEI D'ACCEPTATION MUTUELLE DE
CERTIFICATS D'ESSAIS DES EQUIPEMENTS
ELECTRIQUES (IECEE) METHODE OC

CB TEST CERTIFICATE

Product
Produit

Name and address of the applicant
Nom et adresse du demandeur

Name and address of the manufacturer
Nom et adresse du fabricant

Name and address of the factory
Nom et adresse de l'usine

Note: When more than one factory, please report on page 2
Note: Lorsque il y plus d'une usine, veuillez utiliser la 2^{eme} page

Ratings and principal characteristics
Valeurs nominales et caractéristiques principales

Trademark (if any)
Marque de fabrique (si elle existe)

Type of Manufacturer's Testing Laboratories used
Type de programme du laboratoire d'essais
constructeur

Model / Type Ref.
Ref. De type

Additional information (if necessary may also be
reported on page 2)
Les informations complémentaires (si nécessaire,,
peuvent être indiqués sur la 2^{eme} page

A sample of the product was tested and found
to be in conformity with
Un échantillon de ce produit a été essayé et a été
considéré conforme à la

As shown in the Test Report Ref. No. which forms part
of this Certificate
Comme indiqué dans le Rapport d'essais numéro de
référence qui constitue partie de ce Certificat

CERTIFICAT D'ESSAI OC

Low Voltage Solid State Overcurrent Protectors

TEXAS INSTRUMENTS INC
MS 8712 12500 TI BLVD
DALLAS TX 75243
UNITED STATES

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MS 8712 12500 TI BLVD
DALLAS TX 75243
UNITED STATES

TEXAS INSTRUMENTS DE MEXICO S DE R L DE C V
JESUS RIVERA FRANCO # 507 CD INDUSTRIAL 20290
AGUASCALIENTES AGS
MEXICO

Additional Information on page 2

See page 2



See Page 2

Additionally evaluated to EN 60950-1:2006 /A11:2009 /A1:2010
/A12:2011 /A2:2013. National Differences specified in the CB Test
Report.

Additional Information on page 2

IEC 60950-1(ed.2), IEC 60950-1(ed.2);am1, IEC
60950-1(ed.2);am2

E169910-A38-CB-1 issued on 2016-06-20

This CB Test Certificate is issued by the National Certification Body
Ce Certificat d'essai OC est établi par l'Organisme **National de Certification**



- UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA
- UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK
- UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN
- UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

For full legal entity names see www.ul.com/ncbnames

Date: 2016-06-20

Signature:

Jolanta M. Wroblewska



Ref. Certif. No.

US-27819-UL

Model Details:

TPS2061,TPS2062-1,TPS2062,TPS2065-1,TPS2065,TPS2066-1,TPS2066 maybe followed by alphanumeric suffixes.

Factories:

TEXAS INSTRUMENTS SEMICONDUCTOR MANUFACTURING (CHENGDU) CO., LTD.
NO. 8-8 & NO.8-10, KEXIN RD WEST ZONE OF CHENGDU HI-TECH INDUSTRIAL DEVELOPMEN CHENGDU SICHUAN CHINA

TEXAS INSTRUMENTS TAIWAN LTD
142 HSIN NAN RD, SEC 1 CHUNG HO TAIPEI HSIEN 235 TAIWAN

ASE ASSEMBLY & TEST (SHANGHAI) LTD
#669 GUOSHOUJING RD ZHANGJIANG HI-TECH PARK PUDONG NEW AREA SHANGHAI 201203 CHINA

UTAC THAI LTD
WELGROW INDUSTRIAL ESTATE, 73 MOO5 BANGNA-TRAD (KM 38) RD A BANGPAKONG, T BANGSAMAK CHACHOENGSAO 24180 THAILAND

NANTONG FUJITSU MICROELECTRONICS CO LTD
NO 288 CHONGCHUAN RD CHONGCHUAN DEVELOPMENT ZONE NANTONG JIANGSU 226006 CHINA

TEXAS INSTRUMENTS MALAYSIA SDN BHD
1 LORONG ENGGANG 33 AMPANG/ULU KLANG 54200 KUALA LUMPUR MALAYSIA

HANA MICROELECTRONICS CO LTD (JIA XING)
18 HANA RD XINCHENG INDUSTRIAL PARK XIUZHOU DISTRICT JIAXING ZHEJIANG 314000 CHINA

TI (PHILIPPINES) INC
CLARK TI SPECIAL ECONOMIC ZONE CLARK FREEPORT ZONE ANGELES PAMPANGA PHILIPPINES

HANA SEMICONDUCTOR (AYUTTHAYA) CO LTD
HI-TECH IND ESTATE AUTH OF THAILAND 100 MOO1, T BAAN-LEN, A BANG PA-IN KM 59 ASIA RD AYUTTHAYA 13160 THAILAND

CARSEM SEMICONDUCTOR CO LTD
NO 88 WEST SHEN HU ROAD IN DISTRICT 2 SUZHOU INDUSTRIAL PARK JIANGSU 215021 CHINA

Ratings:

Input Voltage: 2.7-5.5 Vdc

Output Continuous Rating: 1.0 A/output

Number of Outputs: 1 or 2

Output Current Limit: 5.0 A

Ambient: -40 to 85°C

Additional information (if necessary)

Information complémentaire (si nécessaire)



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